

FINAL VERSION

VERSION FINALE



**Surface mounting technology –
Part 4: Classification, packaging, labelling and handling of moisture sensitive
devices**

**Technique du montage en surface (SMT) –
Partie 4: Classification, emballage, étiquetage et manipulation des dispositifs
sensibles à l'humidité**

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

SURFACE MOUNTING TECHNOLOGY –

**Part 4: Classification, packaging,
labelling and handling of moisture sensitive devices**

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This Consolidated version is not an official IEC Standard and has been prepared for user convenience. Only the current versions of the standard and its amendment(s) are to be considered the official documents.

This Consolidated version of IEC 61760-4 bears the edition number 1.1. It consists of the first edition (2015-05) [documents 91/1244/FDIS and 91/1259/RVD] and its amendment 1 (2018-03) [documents 91/1419/CDV and 91/1486/RVC]. The technical content is identical to the base edition and its amendment.

This Final version does not show where the technical content is modified by amendment 1. A separate Redline version with all changes highlighted is available in this publication.

International Standard IEC 61760-4 has been prepared by IEC technical committee 91: Electronics assembly technology.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61760, published under the general title *Surface mounting technology*, can be found on the IEC website.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

Due to the higher temperature profiles of reflow soldering processes using tin-silver-copper alloys or other lead-free solder alloys with higher melting temperatures than Sn-Pb eutectic solder, the sensitivity of components against soldering heat, when being exposed to moisture before soldering, becomes an increasingly important factor.

The currently existing standards describing the moisture sensitivity classification of devices are applicable for plastic encapsulated semiconductors and similar solid state packages (e.g. IEC 60749-20), but not for other types of components.

This part of IEC 61760 also extends the classification and packaging methods as described in J-STD-020 and J-STD-033. It is intended to be used for such type of components, when J-STD-020 and J-STD-033 are not required or not appropriate.

It is important to note that moisture sensitivity levels existing in both J-STD-020 and IEC 61760-4 are equivalent.

SURFACE MOUNTING TECHNOLOGY –

Part 4: Classification, packaging, labelling and handling of moisture sensitive devices

1 Scope

This part of IEC 61760 specifies the classification of moisture sensitive devices into moisture sensitivity levels related to soldering heat, and provisions for packaging, labelling and handling.

This part of IEC 61760 extends the classification and packaging methods to such components, where currently existing standards are not required or not appropriate. For such cases this standard introduces additional moisture sensitivity levels and an alternative method for packaging.

This standard applies to devices intended for reflow soldering, and surface mount devices, including specific through-hole devices (where the device supplier has specifically documented support for reflow soldering), but not to

- semiconductor devices,
- devices for flow (wave) soldering.

NOTE Background of this standard and its relation to currently existing standards, e.g. IEC 60749-20 or J-STD-020 and J-STD-033, are described in the INTRODUCTION.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-1, *Environmental testing – Part 1: General and guidance*

IEC 60749-20, *Semiconductor devices – Mechanical and climatic test methods – Part 20: Resistance of plastic encapsulated SMDs to the combined effect of moisture and soldering heat*

IEC 61340-5-1, *Electrostatics – Part 5-1: Protection of electronic devices from electrostatic phenomena – General requirements*

IEC 61760-2, *Surface mounting technology – Part 2: Transportation and storage conditions for surface mounting devices (SMD) – Application guide*

JPCA/JEDEC J-STD-020E, January 2015, *Moisture/Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.